

<b>Notice of References Cited</b>	Application/Control No. 10/726,532		Applicant(s)/Patent Under Reexamination BOLDER ET AL.	
	Examiner Thuy Dao		Art Unit 2192	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Using observation and refinement to improve distributed systems test", Carr et al., April 2003, pp. 1-7. Online retrieved at < <a href="http://ieeexplore.ieee.org/stamp/26736">http://ieeexplore.ieee.org/stamp/26736</a> >.
	V	"Using XML as a flexible, portable test script language", Johnson et al., December 2003, pp. 1-6. Online retrieved at < <a href="http://ieeexplore.ieee.org/stamp/01243576">http://ieeexplore.ieee.org/stamp/01243576</a> >.
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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